

Search Notes

Application/Control No.

10/672,672

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under
Reexamination

YOSHIDA ET AL.

Art Unit

1745

SEARCHED

Class	Subclass	Date	Examiner
429	12	9/22/2006	DWY
429	34	9/22/2006	DWY
429	35	9/22/2006	DWY
429	36	9/22/2006	DWY
updated	above Search	8/29/2007	THP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search History Printout		8/29/2007	THP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PG Pub, US PAT, USOCR, EPO, JPO, Derwent) - see search history printout	9/22/2006	DWY
Inventor Name Search	8/29/2007	THP